

Search Notes

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Examiner

Chuck Huynh

Applicant(s)/Patent under
Reexamination

BARKAN, YUVAL

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	10/6/2006	CH
455	450	10/6/2006	CH

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass	10/6/2006	CH
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